

# Search Notes



Application No.

09/623,040

Examiner

Bernard E Souw

Applicant(s)

AKIYAMA ET AL.

Art Unit

2881

## SEARCHED

Class	Subclass	Date	Examiner
250	492.1		
	492.21		
	492.22		
	492.3	12/04/03	BES
	396R		
	397		
	398		
	306		
	307		
250	309		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
250	492.22		
	492.1	12/04/03	BES
	492.21		
492.22, 492.3, 396R, 397, 398, 306, 307, 309			

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
(CPB or charged particle beam)	12/04/03	BES
+ [magnet (deflect or scan)]		
+ [lower a supply]		
with filter]		